



Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 282651US8X		SERIAL NO. 09/897,910	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Richard STIRLING-GALLACHER, et al.		GROUP 2618	
				FILING DATE July 3, 2001			
				U.S. PATENT DOCUMENTS			
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
	AA	5,375,123	12/20/1994	Claes H. ANDERSSON			
	AB	5,905,946	05/18/1999	Jorma LILLEBERG, et al.			
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FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO			
	AO EP 0 499 560 B1	08/19/1992	EUROPE				X
	AP EP 0 711 044 A2	05/08/1996	EUROPE				
	AQ WO 98/32268	07/23/1998	WIPO				
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AS	Peter HOEHER, et al., "TWO-DIMENSIONAL PILOT-SYMBOL-AIDED CHANNEL ESTIMATION BY WIENER FILTERING", IEEE, 1997, pages 1845-1848					
	AT	Takeshi ONIZAWA, et al., "A Simple Adaptive Channel Estimation Scheme for OFDM Systems", IEEE, 1999, pages 279-283					
	AU	Jan-Jaap van de BEEK, et al., "On Channel Estimation in OFDM SYSTEMS", IEEE, 1995, pages 815-819					
	AV	J. STOTT, "The effects of phase noise in COFDM", BBC Research & Development, EBU Technical Review, Summer 1998, pages 1-22					
	AW	Patrick ROBERTSON, et al., "Analysis of the Effects of Phase-Noise in Orthogonal Frequency Division Multiplex (OFDM) Systems", IEEE, 1995, pages 1652-1657					
	AX	Fatih SAID, et al., "LINEAR TWO DIMENSIONAL PILOT ASSISTED CHANNEL ESTIMATION FOR OFDM SYSTEMS", IEEE, 29 March - 1 April 1998, pages 32-36					
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner				/Raymond Dean/		Date Considered 10/15/2009	

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.